

substance: CeH_x

property: crystal structure, physical properties

crystal structure	cubic (O _h ⁵ – Fm3m)	72L1, 72L2
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lattice parameter

<i>a</i>	5.539 Å	x = 3	66H
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electrical conductivity

σ	$\approx 10 \Omega^{-1} \text{ cm}^{-1}$	x = 2.81, n-type	69L
	$\approx 3 \Omega^{-1} \text{ cm}^{-1}$	x = 2.85	69L, 72L1

activation energy for conductivity

E_A	0.104 eV	x = 2.81, $T = 200 \text{ K}$	72L2
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CeH_{2+x} [95V]

semiconductor:	x = 0.70		M-SC transition: $T = 260(10) \text{ K}$ (heating)	88S
ρ	5500 $\mu\Omega\text{cm}$	$T = 260 \text{ K}$		
semiconductor:	x = 0.78		M-SC transition: $T = 230(10) \text{ K}$ (heating)	88S
ρ	2400 $\mu\Omega\text{cm}$	$T = 230 \text{ K}$		
semiconductor:	x = 0.715		M-SC transition: $T = 245(5) \text{ K}$ (cooling)	72L1
ρ	$1 \cdot 10^4 \mu\Omega\text{cm}$	$T = 245 \text{ K}$		
semiconductor:	x = 0.74		M-SC transition: $T = 200(10) \text{ K}$ (cooling)	72L1
ρ	$1.7 \cdot 10^4 \mu\Omega\text{cm}$	$T = 200 \text{ K}$		
semiconductor:	x = 0.77		M-SC transition: $T = 220(5) \text{ K}$ (cooling)	72L1
ρ	$2.3 \cdot 10^4 \mu\Omega\text{cm}$	$T = 220 \text{ K}$		

normalized resistivity vs. T : Fig. 3,
XPS-spectrum: Fig. 1, UPS-spectrum: Fig. 2

Further figures and references:

crystal structure: Fig. 4

lattice parameter vs. x: Fig. 6

metal-semiconductor transition for $x \geq 2.7$ [72L1, 79D, 81F1]

heat capacity [65B]; temperature dependence of heat capacity ($x = 2.7, 2.96$): Fig. 5

energy bands ($x = 3$): Fig. 7

density of states ($x = 3, 2.75$): Figs. 8, 9

XPS spectra ($x = 2.9$): Figs. 10, 11

Hall coefficient: Fig. 12

charge carrier concentration: Fig. 13

Seebeck coefficient: Fig. 14

resistivity dependence on x: Fig. 15; temperature dependence of resistivity for $x = 2.77, 2.81, 2.85$: Figs. 16, 17, 18

optical phonon energies 110 meV and 65 meV for $x = 2.72$ [74V];

electron phonon interaction [81F2]

References:

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Fig. 1.

RH_x . Valence band spectra for La, Y, Ce, and Pr and for their phase boundary and trihydride compositions from XPS. Data for the metals are shown by dotted lines [85O].

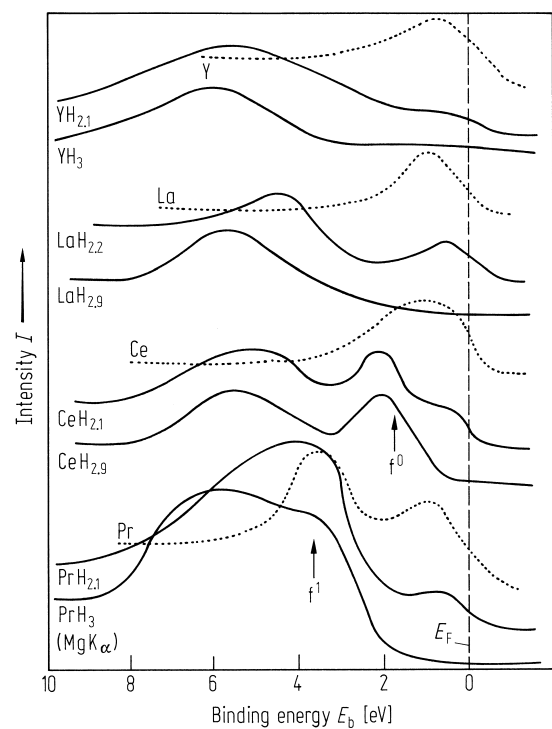


Fig. 2.

RH_x. UPS photoemission data for hydrides of La, Ce, Gd, and Tb at binding energies near the Fermi level [87S].

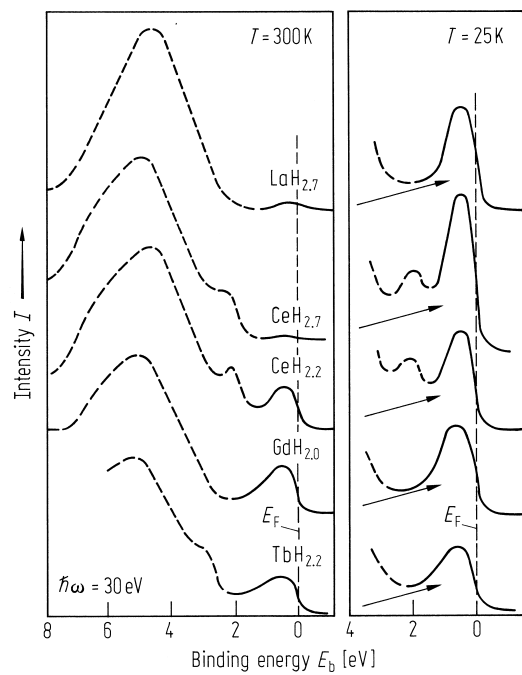


Fig. 3.

CeH_{2+x} . Normalized resistivity $\rho(T)/\rho(295\text{K})$ as a function of the (inverse) temperature, showing metal-semiconductor transitions and pure semiconductor behaviour. The actual H content of the $\text{CeH}_{2.81}$ sample was probably somewhat higher than indicated [89S].

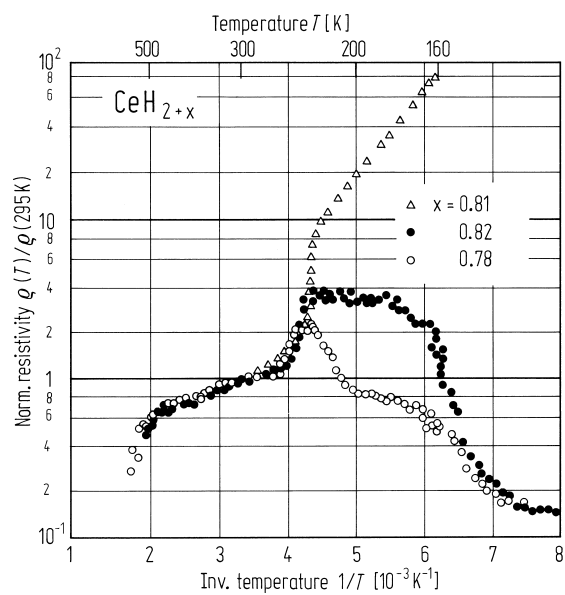


Fig. 4.

REH_x . Unit cell of the CaF_2 -type structure.

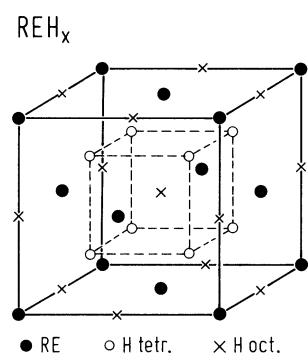


Fig. 5.

RH_x , $\text{R} = \text{La, Ce, Pr, Nd, Sm}$. Molar heat capacities vs. temperature. The maxima at about 250 K are attributed to metal-semiconductor transitions. No anomaly was found for $\text{CeH}_{2.96}$ and $\text{SmH}_{2.84}$ in this temperature range [79B].

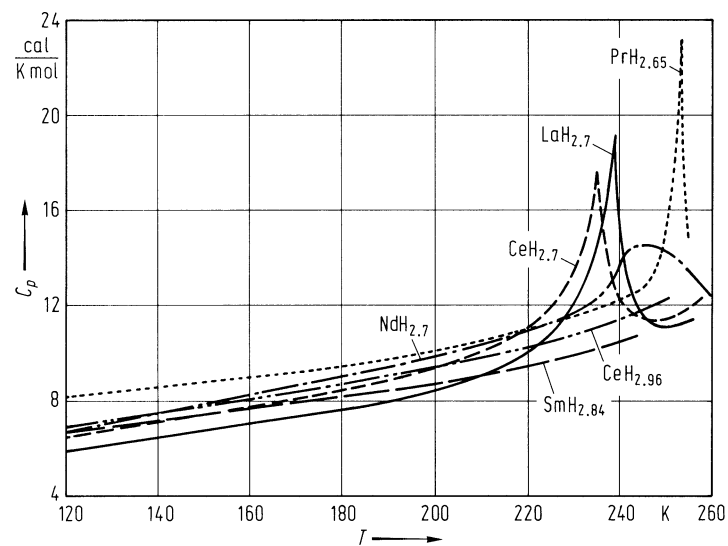


Fig. 6.

CeH_x . Lattice parameter as a function of hydrogen concentration [68M].

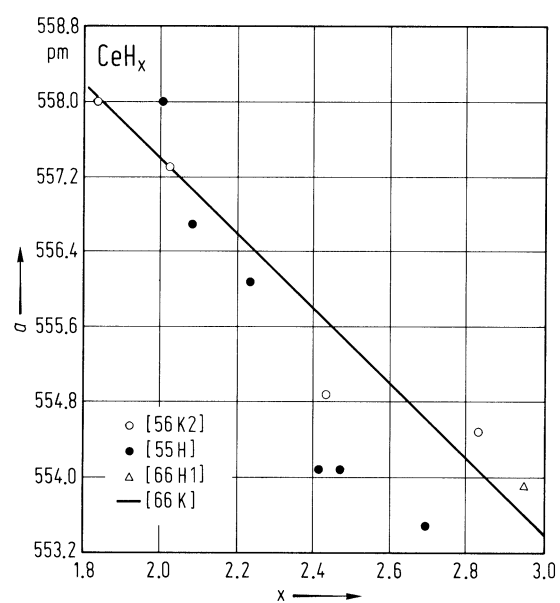


Fig. 7.

CeH₃. Energy bands obtained from an APW calculation [80F].

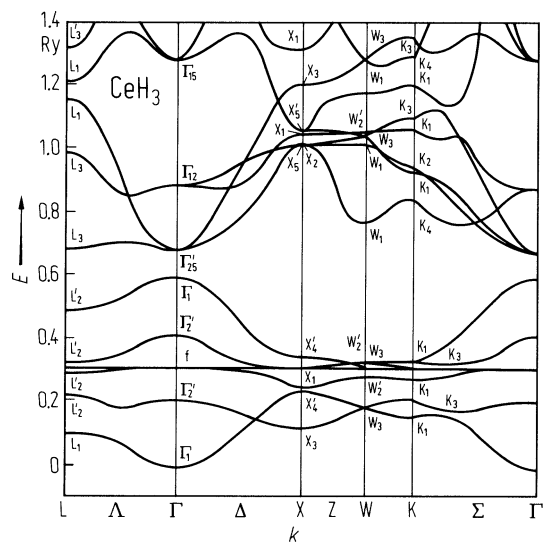


Fig. 8.

CeH₃. Partial and total density of states [80F]. H_{oct}, H_{tetr}: octahedral and tetrahedral H, respectively.

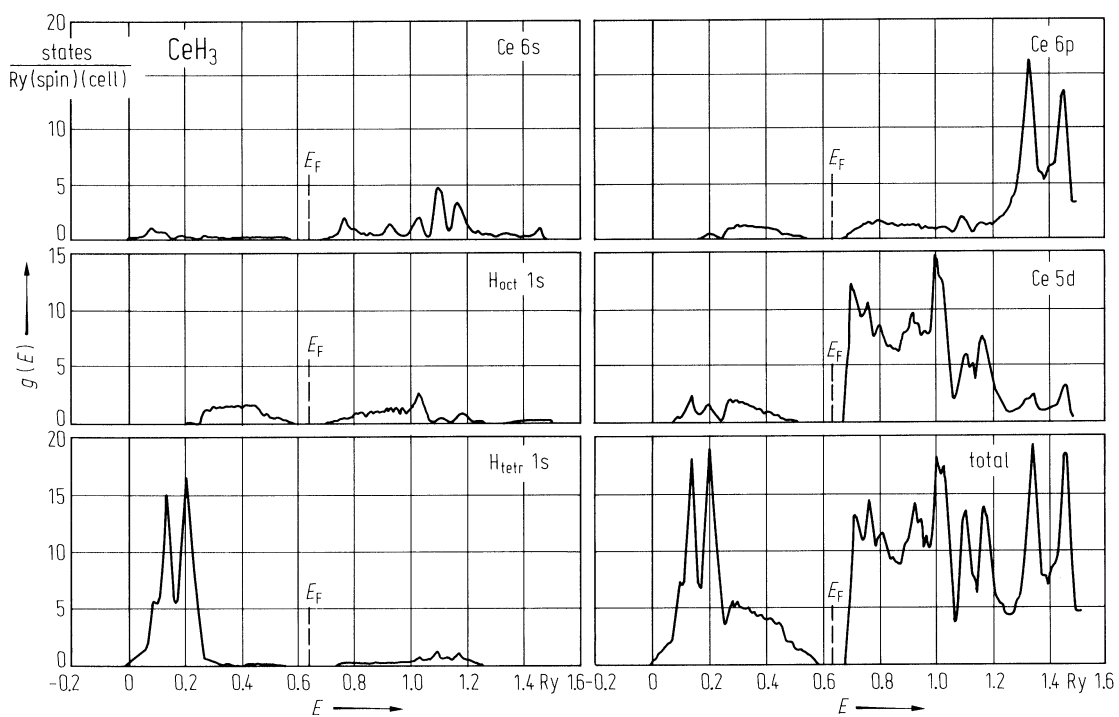


Fig. 9.

CeH_{2.75}. Density of states for bct and cubic supercells [81F1].

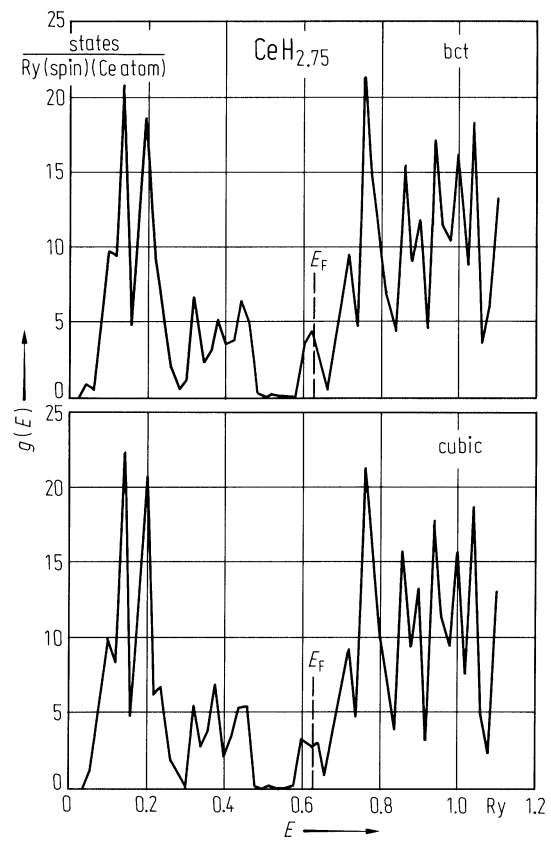


Fig. 10.

CeH_{2.9}, Ce. XPS-spectra (intensity vs. binding energy). A comparison of 3d core level spectra [82S].

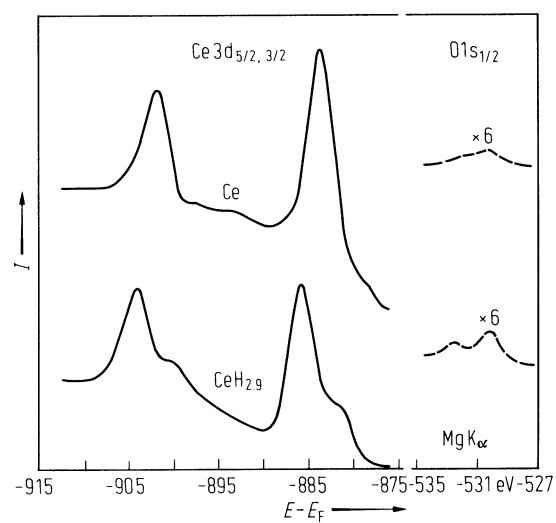


Fig. 11.

CeH_{2.9}, Ce. XPS valence band and 5p core level spectra (intensity vs. binding energy) [82S].

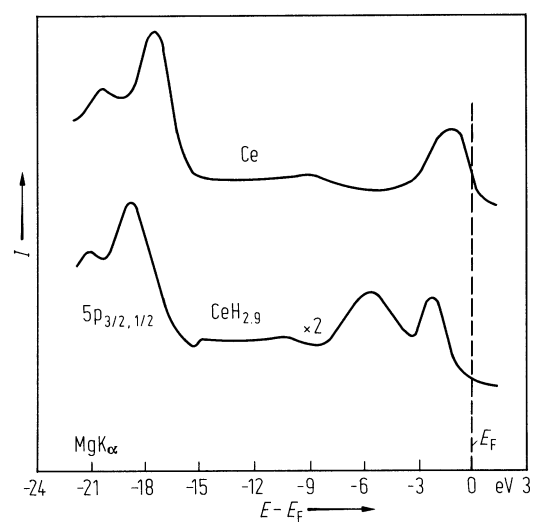


Fig. 12.

CeH_x . Hall coefficient vs. composition in the rang $2.0 \leq x \leq 2.8$ [69H].

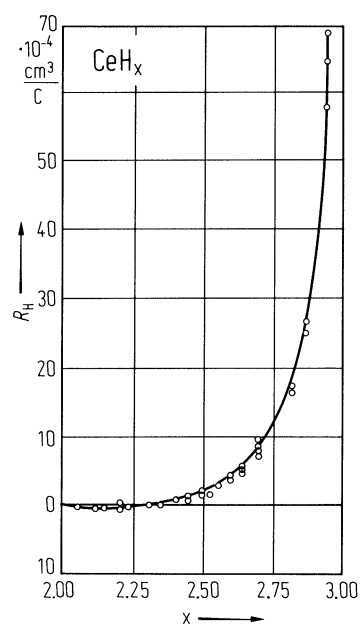


Fig. 13.

CeH_x . Charge carrier concentration vs. composition for $2.3 \leq x \leq 2.8$. The straight line is predicted for the case of one hole removed for each hydrogen added [69H].

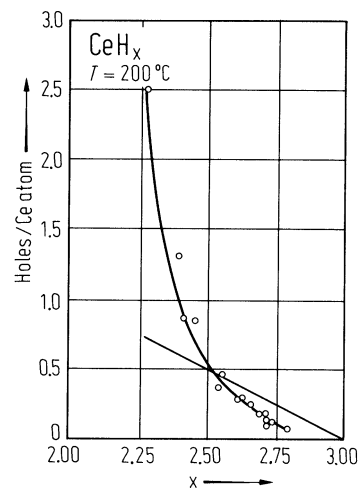


Fig. 14.

CeH_x . Seebeck coefficient vs. temperature for several compositions [72L1].

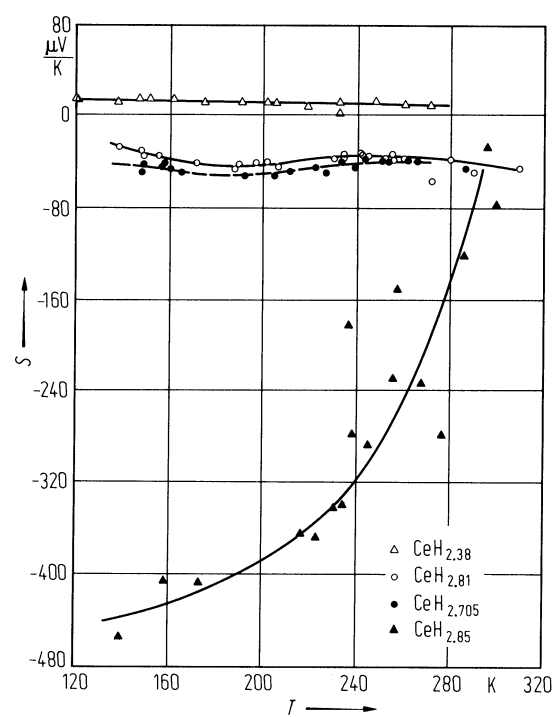


Fig. 15.

CeH_x . Resistivity vs. composition. Measurements by various authors [72L1].

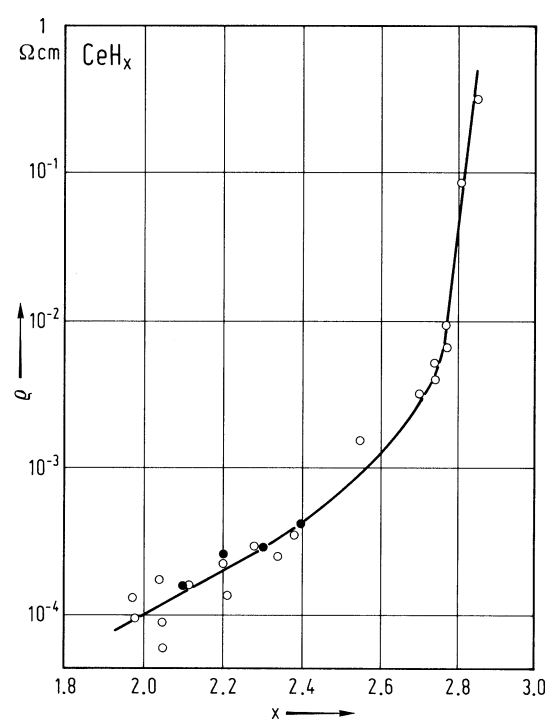


Fig. 16.

CeH_{2.77}. Resistivity vs temperature [72L1].

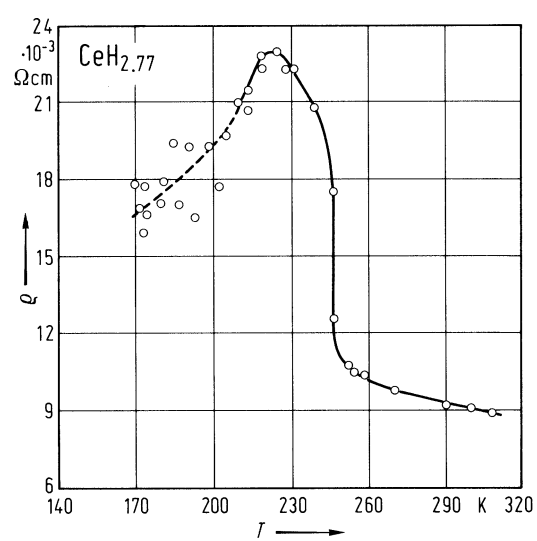


Fig. 17.

CeH_{2.81}. Resistivity vs. reciprocal temperature [72L2].

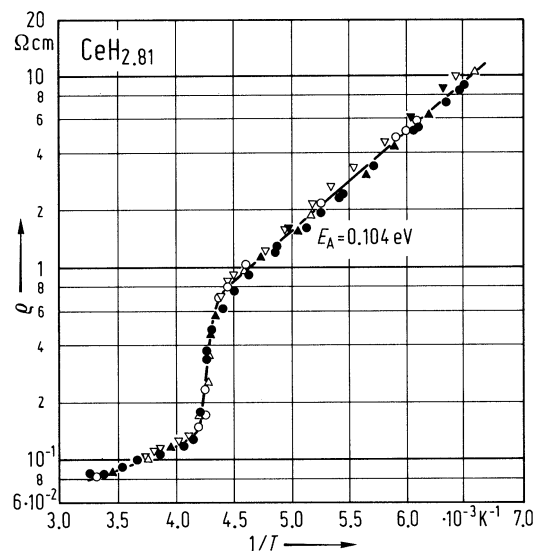


Fig. 18.

CeH_{2.85}. Resistivity vs. (reciprocal) temperature [69L, 72L1].

